

KSK30

Low Noise PRE-AMP. Use

- High Input Impedance: I_{GSS}=1nA (MAX)
 Low Noise: NF=0.5dB (TYP)
- High Voltage: V_{GDS}= -50V



1. Source 2. Gate 3. Drain

Silicon N-channel Junction Fet

Absolute Maximum Ratings T_a =25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{GDS}	Gate-Drain Voltage	-50	V
I _G	Gate-Current	10	mA
P _C	Collector Dissipation	100	mW
T _J	Junction Temperature	125	°C
T _{STG}	Storage Temperature	-55 ~ 125	°C

Electrical Characteristics T_a=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV _{GDS}	Gate-Drain Breakdown Voltage	V _{DS} =0, I _G = -100μA	-50			V
I _{GSS}	Gate Leak Current	V _{GS} = -30V, V _{DS} =0			-1	nA
I _{DSS}	Drain Leak Current	V _{DS} =10V, V _{GS} =0	0.3		6.5	mA
V _{GS} (off)	Gate-Source Voltage	V _{DS} =10V, I _D =0.1μA	-0.4		-5	V
Y _{FS}	Forward Transfer Admittance	V _{DS} =10V, V _{GS} =0, f=1KHz	1.2			mS
C _{ISS}	Input Capacitance	V _{DS} =0, V _{GS} =0, f=1MHz		8.2		pF
C _{RSS}	Feedback Capacitance	V _{GD} =10V, V _{DS} =0 f=1MHz		2.6		pF
NF	Noise Figure	V_{DS} =15V, V_{GS} =0 R _G =100K Ω f=120Hz		0.5	5	dB

I_{DSS} Classification

Classification	R	0	Υ	G
I _{DSS} (mA)	0.30 ~ 0.75	0.60 ~ 1.40	1.20 ~ 3.00	2.60 ~ 6.50

Typical Characteristics

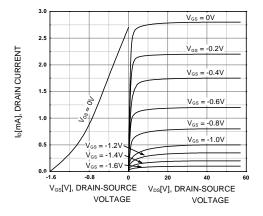


Figure 1. Static Characteristic

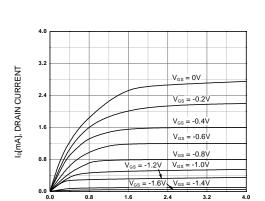


Figure 3. I_D - V_{DS}

 $V_{DS}[V]$, DRAIN-SOURCE VOLTAGE

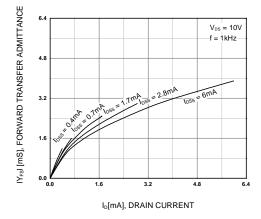


Figure 5. |Yfs |-I_D

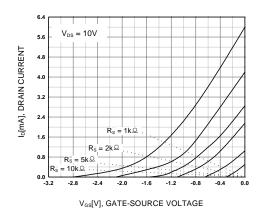


Figure 2. I_D - V_{GS}

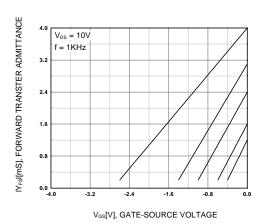


Figure 4. | Yfs | -V_{GS}

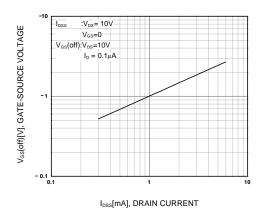


Figure 6. V_{GS}(off)-I_{DSS}

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 $V_{DS} = 15V$

 $I_D = 1 \text{mA}$

Typical Characteristics (Continued)

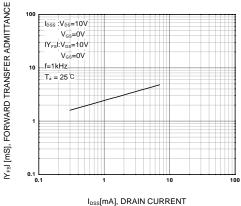
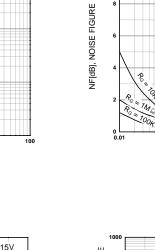


Figure 7. | Yfs | -I_{DSS}



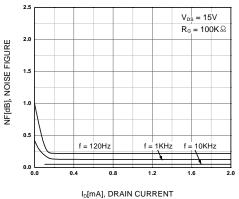


Figure 9. NF-I_D

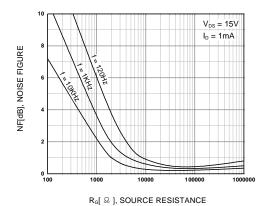
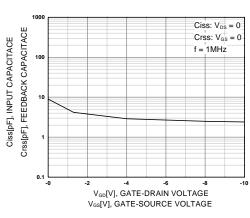


Figure 11. NF-R_G



 $V_{\text{GS}}[V]$, GATE-SOURCE VOLTAGE

Figure 8. NF-f

Figure 10. Ciss- V_{GS} , Crss- V_{GD}

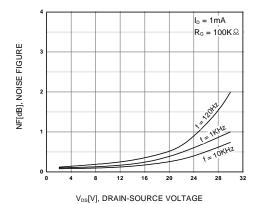


Figure 12. NF-V_{DS}

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Typical Characteristics (Continued)

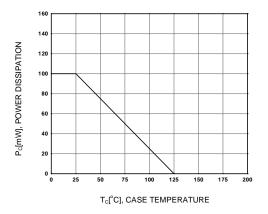
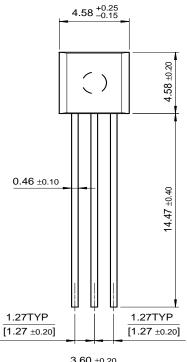


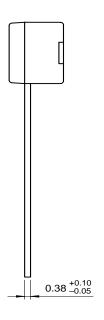
Figure 13. Power Derating

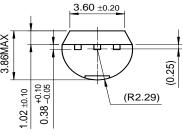
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Package Demensions

TO-92







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